



## Description

The HSISH101DNT1GE3 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

## General Features

$V_{DS} = -30V$   $I_D = -70A$

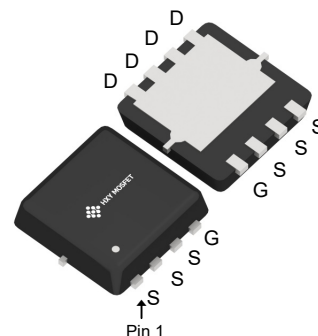
$R_{DS(ON)} < 9.3m\Omega$  @  $V_{GS} = -10V$

## Application

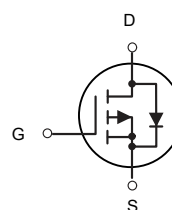
Battery protection

Load switch

Uninterruptible power supply



DFN3X3-8L



P-Channel MOSFET

## Package Marking and Ordering Information

| Product ID      | Pack      | Brand      | Qty(PCS) |
|-----------------|-----------|------------|----------|
| HSISH101DNT1GE3 | DFN3X3-8L | HXY MOSFET | 5000     |

## Absolute Maximum Ratings ( $T_C = 25^\circ C$ unless otherwise noted)

| Symbol                   | Parameter                                     | Rating     | Units        |
|--------------------------|-----------------------------------------------|------------|--------------|
| VDS                      | Drain-Source Voltage                          | -30        | V            |
| VGS                      | Gate-Source Voltage                           | $\pm 20$   | V            |
| $I_D @ T_C = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V^1$    | -70        | A            |
| $I_D @ T_C = 75^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V^1$    | -35        | A            |
| IDM                      | Pulsed Drain Current <sup>2</sup>             | -175       | A            |
| EAS                      | Single Pulse Avalanche Energy <sup>3</sup>    | 31         | mJ           |
| $P_D @ T_C = 25^\circ C$ | Total Power Dissipation <sup>4</sup>          | 31.2       | W            |
| TSTG                     | Storage Temperature Range                     | -55 to 150 | $^\circ C$   |
| TJ                       | Operating Junction Temperature Range          | -55 to 150 | $^\circ C$   |
| $R_{\theta JC}$          | Thermal Resistance Junction-Case <sup>1</sup> | 4          | $^\circ C/W$ |



**Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)**

| Parameter                                |                   | Symbol        | Test Conditions                                             | Min. | Typ. | Max.      | Unit    |
|------------------------------------------|-------------------|---------------|-------------------------------------------------------------|------|------|-----------|---------|
| Static Characteristics                   |                   |               |                                                             |      |      |           |         |
| Drain-Source Breakdown Voltage           |                   | $V_{(BR)DSS}$ | $V_{GS} = 0V, I_D = -250\mu A$                              | -30  | -    | -         | V       |
| Gate-body Leakage current                |                   | $I_{GSS}$     | $V_{DS} = 0V, V_{GS} = \pm 20V$                             | -    | -    | $\pm 100$ | nA      |
| Zero Gate Voltage Drain Current          | $T_J=25^{\circ}C$ | $I_{DSS}$     | $V_{DS} = -24V, V_{GS} = 0V$                                | -    | -    | -1        | $\mu A$ |
|                                          | $T_J=55^{\circ}C$ |               |                                                             | -    | -    | -5        |         |
| Gate-Threshold Voltage                   |                   | $V_{GS(th)}$  | $V_{DS} = V_{GS}, I_D = -250\mu A$                          | -1.0 | -1.6 | -2.5      | V       |
| Drain-Source On-Resistance <sup>2</sup>  |                   | $R_{DS(on)}$  | $V_{GS} = -10V, I_D = -12A$                                 | -    | 6.5  | 9.3       | mΩ      |
|                                          |                   |               | $V_{GS} = -4.5V, I_D = -8A$                                 | -    | 9.5  | 14.5      |         |
| Forward Transconductance                 |                   | $g_{fs}$      | $V_{DS} = -5V, I_D = -20A$                                  | -    | 28   | -         | S       |
| Dynamic Characteristics                  |                   |               |                                                             |      |      |           |         |
| Input Capacitance                        |                   | $C_{iss}$     | $V_{DS} = -15V, V_{GS} = 0V, f = 1MHz$                      | -    | 4320 | -         | pF      |
| Output Capacitance                       |                   | $C_{oss}$     |                                                             | -    | 529  | -         |         |
| Reverse Transfer Capacitance             |                   | $C_{rss}$     |                                                             | -    | 487  | -         |         |
| Switching Characteristics                |                   |               |                                                             |      |      |           |         |
| Gate Resistance                          |                   | $R_g$         | $V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$                      | -    | 4.0  | -         | Ω       |
| Total Gate Charge                        |                   | $Q_g$         | $V_{GS} = -10V, V_{DS} = -15V, I_D = -15A$                  | -    | 45   | -         | nC      |
| Gate-Source Charge                       |                   | $Q_{gs}$      |                                                             | -    | 8.5  | -         |         |
| Gate-Drain Charge                        |                   | $Q_{gd}$      |                                                             | -    | 12.8 | -         |         |
| Turn-On Delay Time                       |                   | $t_{d(on)}$   | $V_{GS} = -10V, V_{DD} = -15V, R_G = 2.5\Omega, I_D = -15A$ | -    | 18.9 | -         | nS      |
| Rise Time                                |                   | $t_r$         |                                                             | -    | 15.7 | -         |         |
| Turn-Off Delay Time                      |                   | $t_{d(off)}$  |                                                             | -    | 64.8 | -         |         |
| Fall Time                                |                   | $t_f$         |                                                             | -    | 36.5 | -         |         |
| Drain-Source Body Diode Characteristics  |                   |               |                                                             |      |      |           |         |
| Diode Forward Voltage <sup>2</sup>       |                   | $V_{SD}$      | $I_S = -1A, V_{GS} = 0V$                                    | -    | -    | -1        | V       |
| Continuous Source Current <sup>1,5</sup> |                   | $I_S$         | $V_G = V_D = 0V$ , Force Current                            | -    | -    | -65       | A       |

Note :

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 20Z copper.
- 2.The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is  $V_{DD} = -25V, V_{GS} = -10V, L = 0.1mH, I_{AS} = -25A$
- 4.The power dissipation is limited by  $150^\circ\text{C}$  junction temperature
- 5.The data is theoretically the same as  $I_D$  and  $I_{DM}$  , in real applications , should be limited by total power dissipation.



## Typical Characteristics

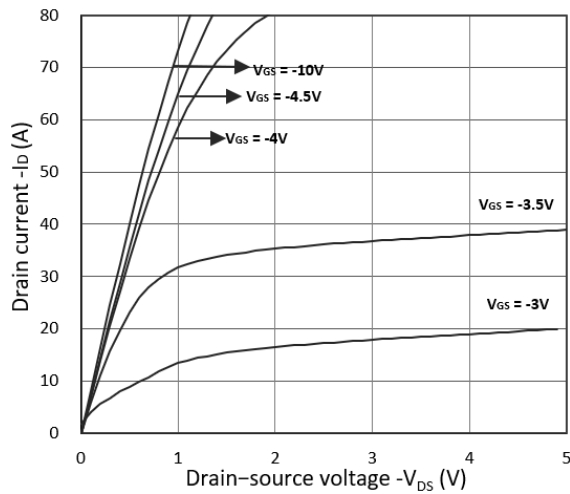


Figure 1. Output Characteristics

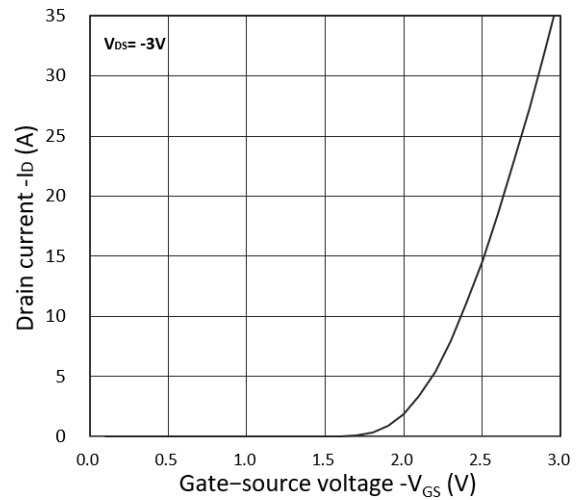


Figure 2. Transfer Characteristics

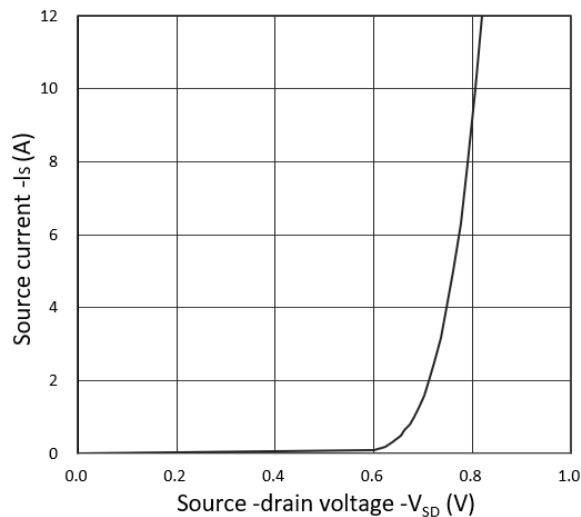


Figure 3. Forward Characteristics of Reverse

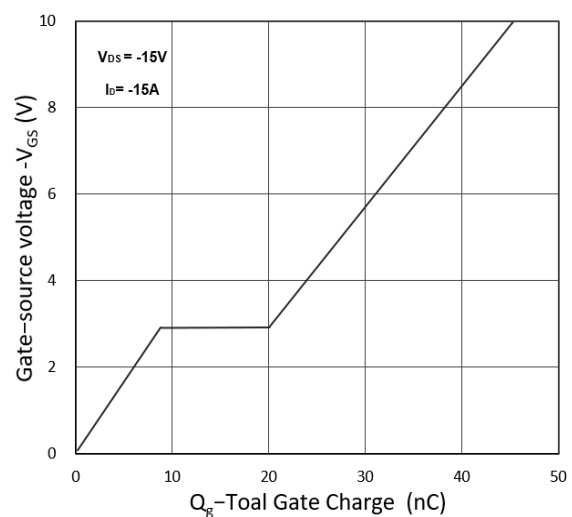


Figure 4. Gate Charge Characteristics

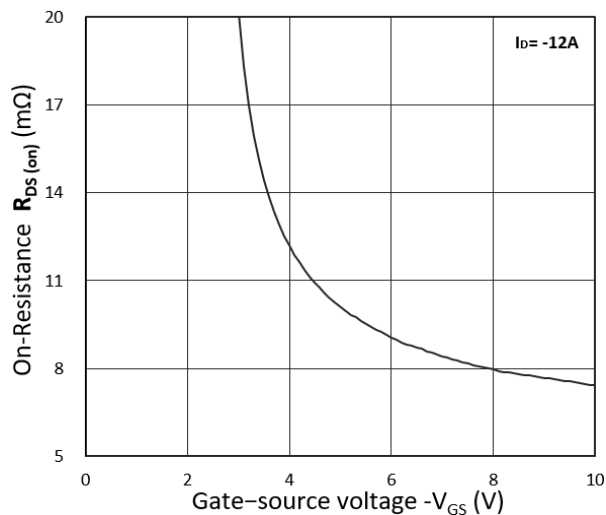


Figure 5.  $R_{DS(on)}$  vs.  $V_{GS}$

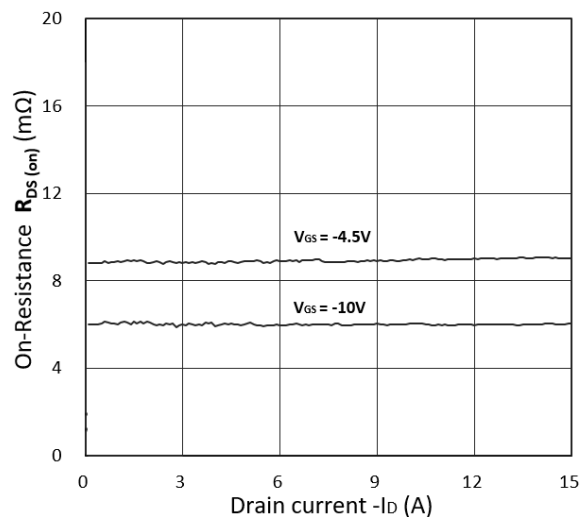


Figure 6.  $R_{DS(on)}$  vs.  $I_D$

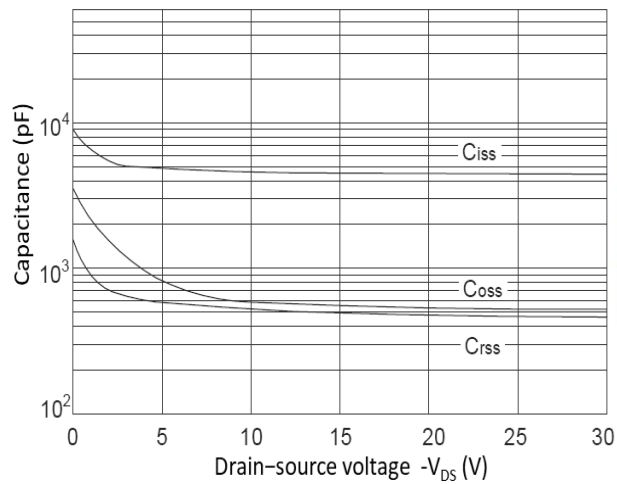


Figure 7. Capacitance Characteristics

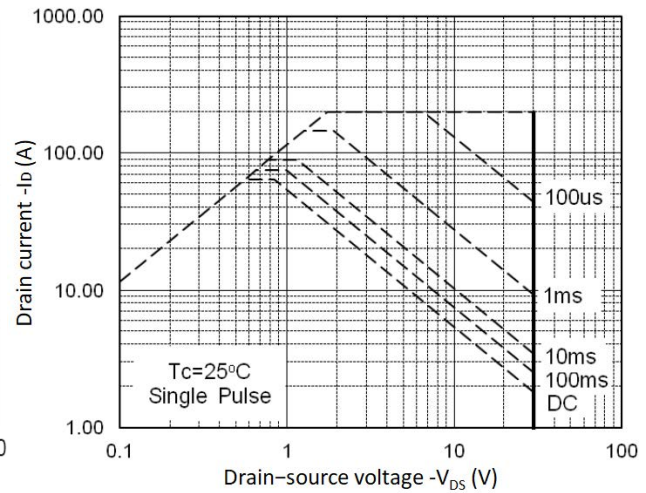


Figure 8. Safe Operating Area

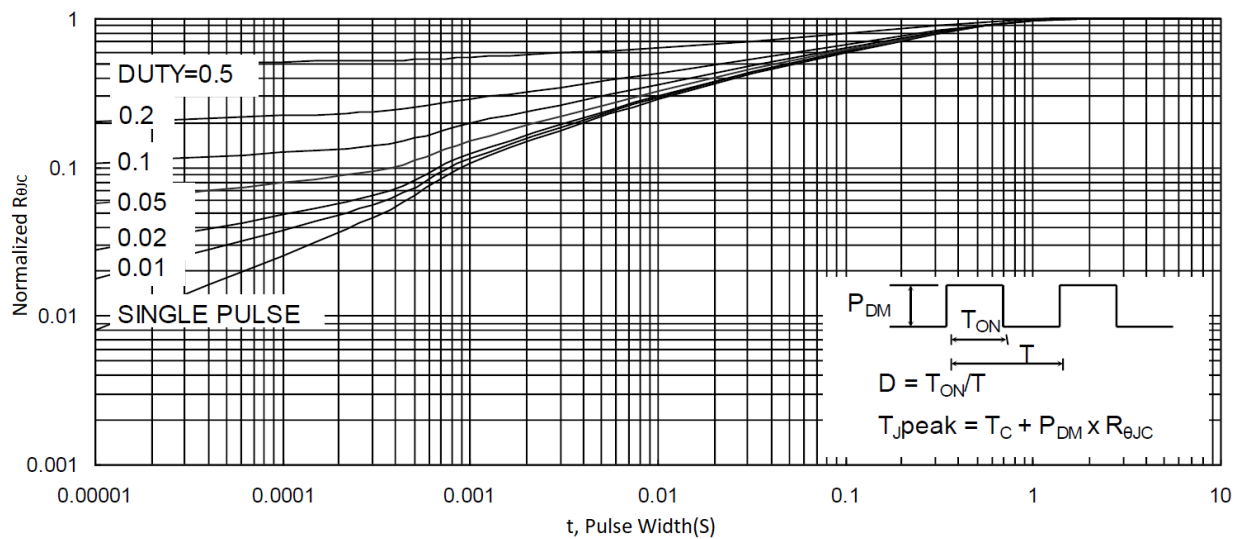


Figure 9. Normalized Maximum Transient Thermal Impedance

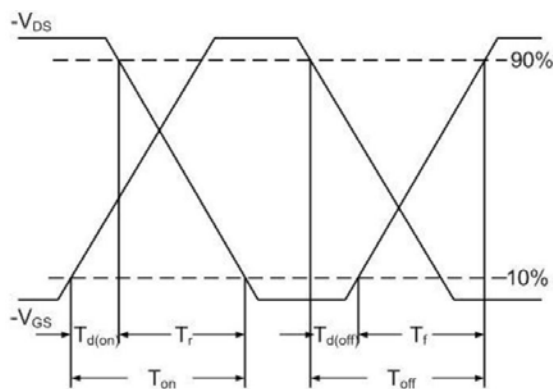


Figure 10. Switching Time Waveform

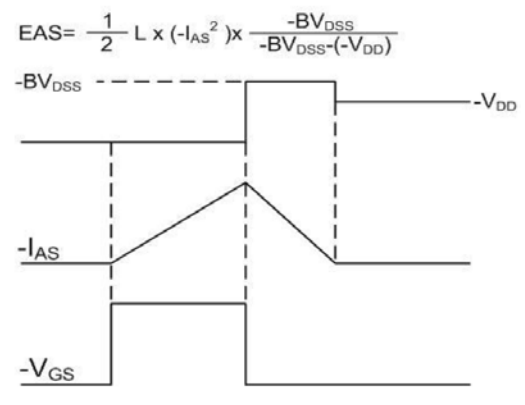
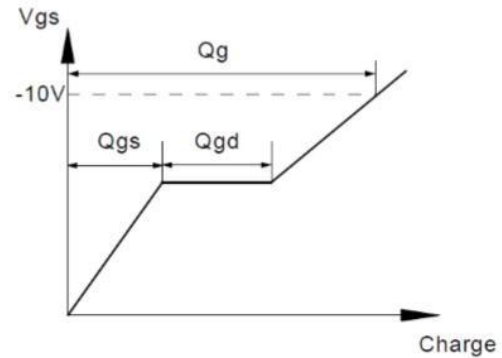
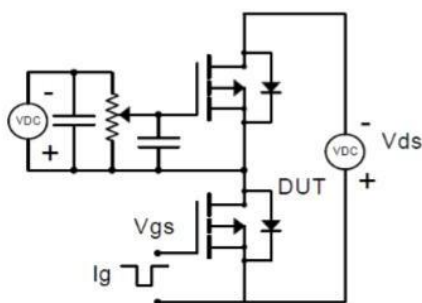


Figure 11. Unclamped Inductive Switching  
Waveform

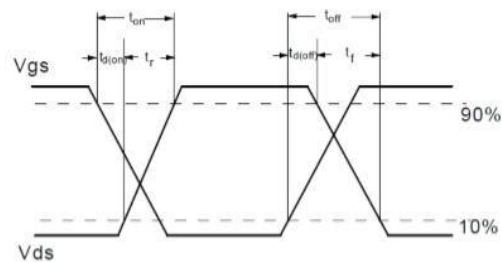
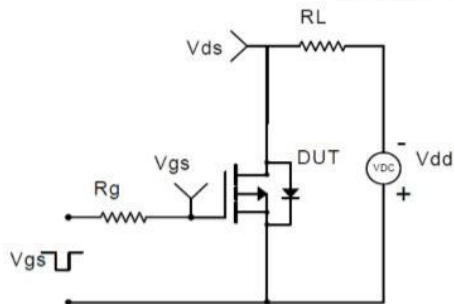


## Test Circuit

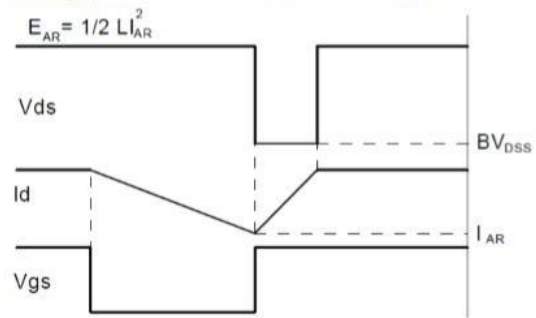
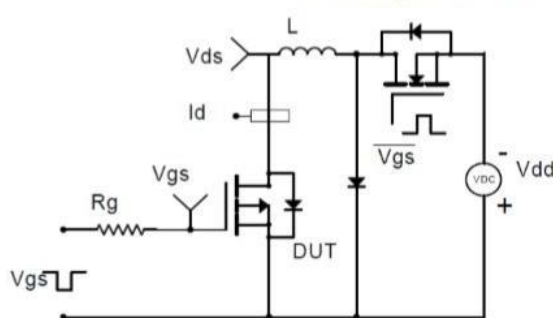
Gate Charge Test Circuit & Waveform



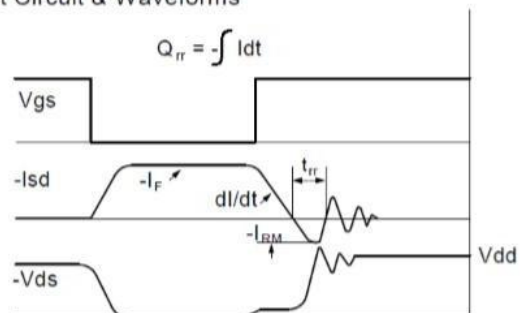
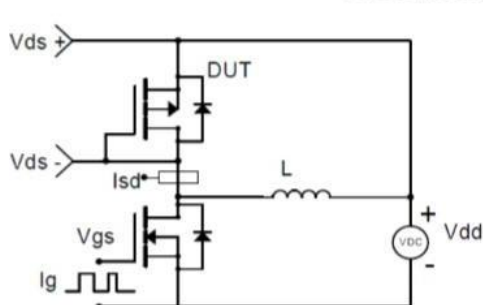
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

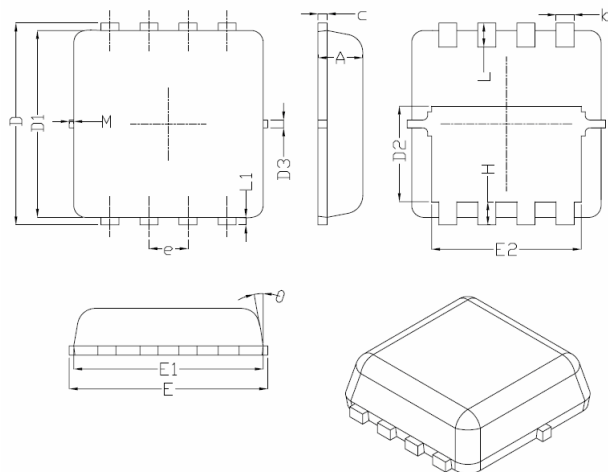


Diode Recovery Test Circuit & Waveforms





## DFN3X3-8L Package Information



| Symbol | Dimensions In Millimeters |      |      |
|--------|---------------------------|------|------|
|        | Min.                      | Nom. | Max. |
| A      | 0.70                      | 0.75 | 0.80 |
| b      | 0.25                      | 0.30 | 0.35 |
| c      | 0.10                      | 0.15 | 0.25 |
| D      | 3.25                      | 3.35 | 3.45 |
| D1     | 3.00                      | 3.10 | 3.20 |
| D2     | 1.48                      | 1.58 | 1.68 |
| D3     | -                         | 0.13 | -    |
| E      | 3.20                      | 3.30 | 3.40 |
| E1     | 3.00                      | 3.15 | 3.20 |
| E2     | 2.39                      | 2.49 | 2.59 |
| e      | 0.65BSC                   |      |      |
| H      | 0.30                      | 0.39 | 0.50 |
| L      | 0.30                      | 0.40 | 0.50 |
| L1     | -                         | 0.13 | -    |
| M      | *                         | *    | 0.15 |
| θ      |                           | 10°  | 12°  |



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